



30V COMPLEMENTARY ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(ON) max}	Package	I _{D MAX} T _A = +25℃
N-Channel	30V	20mΩ @ V _{GS} = 10V		8.5A
		$32m\Omega$ @ $V_{GS} = 4.5V$	SO-8	7.0A
P-Channel	-30V	$45m\Omega$ @ $V_{GS} = -10V$	30-6	-5.5A
		85mΩ @ V _{GS} = -4.5V		-4.1A

Description

This MOSFET is designed to minimize the on-state resistance $(R_{DS(ON)})$ and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Applications

- DC Motor Control
- DC-AC Inverters

Features

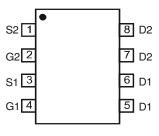
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

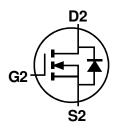
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed Over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.008 grams (Approximate)



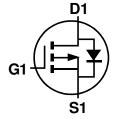
Top View



Pin Configuration



Q2 N-CHANNEL MOSFET



Q1 P-CHANNEL MOSFET

Equivalent Circuit

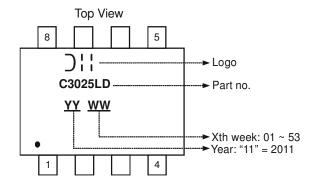
Ordering Information (Note 4)

Part Number	Case	Packaging	
DMC3025LSD-13	SO-8	2,500/Tape & Reel	

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html

Marking Information





Maximum Ratings N-CHANNEL— Q2 (@T_A = +25 ℃, unless otherwise specified.)

Characteristic			Symbol	Value	Units	
Drain-Source Voltage			V _{DSS}	30	V	
Gate-Source Voltage			V _{GSS}	±20	V	
		$T_A = +25$ °C $T_A = +70$ °C	I _D	6.5 5.1	А	
Continuous Drain Current (Note 5) V _{GS} = 10V	t<10s	$T_A = +25$ °C $T_A = +70$ °C	I _D	8.5 6.8	А	
Continuous Drain Current (Note E) V 4 EV	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	5.3 4.1	Α	
Continuous Drain Current (Note 5) V _{GS} = 4.5V	t<10s	$T_A = +25$ °C $T_A = +70$ °C	I _D	7.0 5.5	А	
Maximum Continuous Body Diode Forward Current	(Note 5)		Is	2	Α	
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I _{DM}	60	Α	
Pulsed Body Diode Current (10μs pulse, duty cycle = 1%)			I _{SM}	60	Α	
Avalanche Current (Note 7) L = 0.1mH			I _{AS}	14	Α	
Avalanche Energy (Note 7) L = 0.1mH			E _{AS}	10	mJ	

Maximum Ratings P-CHANNEL— Q1 (@T_A = +25 ℃, unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V _{DSS}	-30	V
Gate-Source Voltage			V _{GSS}	±20	V
		$T_A = +25$ °C $T_A = +70$ °C	I _D	-4.2 -3.2	А
Continuous Drain Current (Note 5) V _{GS} = -10V	t<10s	$T_A = +25$ °C $T_A = +70$ °C	I _D	-5.5 -4.3	А
Continuous Drain Current (Note 5) // 4.5/	Steady State	$T_A = +25$ °C $T_A = +70$ °C	I _D	-3.5 -2.3	Α
Continuous Drain Current (Note 5) V _{GS} = -4.5V	t<10s	$T_A = +25$ °C $T_A = +70$ °C	I _D	-4.1 -3.2	Α
Maximum Continuous Body Diode Forward Current	(Note 5)		I _S	-2	Α
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I _{DM}	-30	Α
Pulsed Body Diode Current (10µs pulse, duty cycle = 1%)			I _{SM}	-30	Α
Avalanche Current (Note 7) L = 0.1mH			I _{AS}	-14	Α
Avalanche Energy (Note 7) L = 0.1mH			E _{AS}	10	mJ

Thermal Characteristics

Characteristic	Symbol	Value	Units		
Total Power Dissipation (Note 6)	T _A = +25℃	D	1.2	W	
Total Fower Dissipation (Note 6)	T _A = +70 °C	P_{D}	0.77	VV	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	Б	104	°C/W	
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	62	G/VV	
Total Bower Dissination (Note 5)	T _A = +25 ℃	D	1.5	W	
Total Power Dissipation (Note 5)	T _A = +70 °C	P_{D}	0.95	VV	
Thermal Desistance Junction to Ambient (Note E)	Steady State	Б	83		
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	49	°C/W	
Thermal Resistance, Junction to Case (Note 5)		$R_{ heta JC}$	15		
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	∞	

Notes:

DMC3025LSD Document number: DS35717 Rev. 7 - 2

^{5.} Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.



Electrical Characteristics N-CHANNEL— Q2 (@T_A = +25 °C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)	, -,		71	_		
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	±1	μΑ	V _{GS} = ±20V, V _{DS} = 0V
ON CHARACTERISTICS (Note 8)						•
Gate Threshold Voltage	V _{GS(th)}	1.0	_	2.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	Б	_	15	20	mΩ	V _{GS} = 10V, I _D = 7.4A
Static Drain-Source On-nesistance	R _{DS (ON)}	_	23	32	11177	$V_{GS} = 4.5V, I_D = 6A$
Forward Transfer Admittance	Y _{fs}	_	8	_	S	V _{DS} = 5V, I _D = 10A
Diode Forward Voltage	V_{SD}	_	0.70	1.2	V	V _{GS} = 0V, I _S = 1A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	_	501	_		$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz
Output Capacitance	Coss	_	72	_	pF	
Reverse Transfer Capacitance	C _{rss}	_	57	_		
Gate Resistance	R_g	_	1.84	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	4.6	_		
Total Gate Charge (V _{GS} = 10V)	Qg	_	9.8	_	nC	V 45V L 40A
Gate-Source Charge	Qgs	_	1.6	_	IIC	$V_{DS} = 15V, I_{D} = 10A$
Gate-Drain Charge	Q _{gd}	_	2.0	_		
Turn-On Delay Time	t _{D(on)}	_	3.9	_		
Turn-On Rise Time	t _r	_	4.2	_		$V_{DD} = 15V, V_{GS} = 10V,$
Turn-Off Delay Time	t _{D(off)}	_	16.6	_	ns	$R_G = 6\Omega$, $I_D = 1A$
Turn-Off Fall Time	t _f	_	5.8	_		
Reverse Recovery Time	t _{rr}	_	5.5	_	ns	1 404 -11/-14 - 5004/-
Reverse Recovery Charge	Q _{rr}	_	2.6	_	nC	I _F = 12A, di/dt = 500A/μs



Electrical Characteristics P-CHANNEL — Q1 (@T_A = +25 °C, unless otherwise specified.)

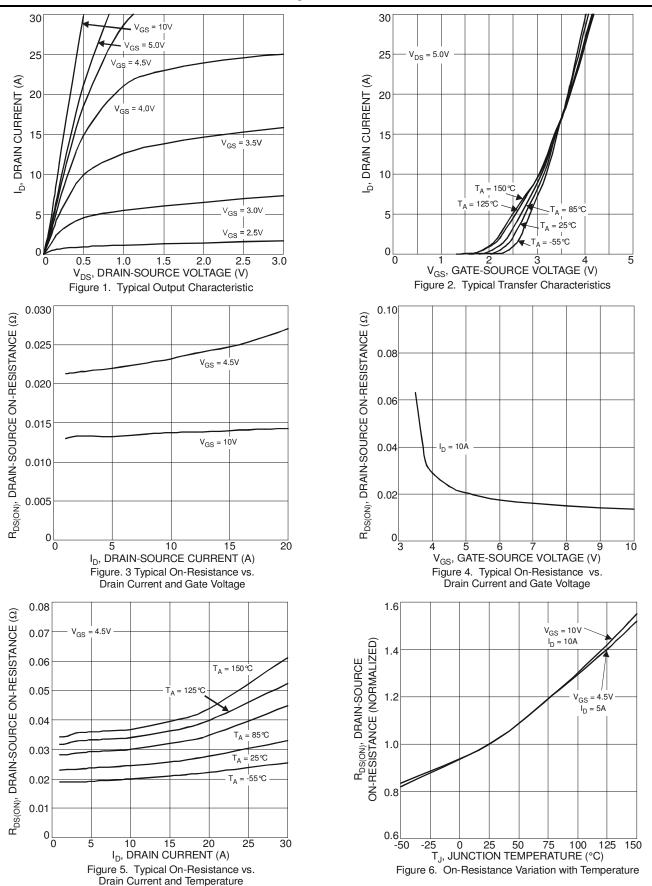
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	-30	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_		-1	μA	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						•
Gate Threshold Voltage	V _{GS(th)}	-1.0	_	-2.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance		_	38	45	mΩ	$V_{GS} = -10V, I_D = -5.2A$
Static Drain-Source On-nesistance	R _{DS} (ON)	_	65	85	11177	$V_{GS} = -4.5V, I_D = -4A$
Forward Transfer Admittance	Y _{fs}	_	5	_	S	$V_{DS} = -5V, I_D = -5.2A$
Diode Forward Voltage	V_{SD}	_	-0.7	-1.2	V	$V_{GS} = 0V, I_{S} = -1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	_	590	_	pF	
Output Capacitance	Coss	_	69	_	pF	$V_{DS} = -25V, V_{GS} = 0V,$ - f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	53	_	pF	-1 = 1.0lvii iz
Gate Resistance	Rg	_	11	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	5.1	_	nC	
Total Gate Charge (V _{GS} = 10V)	Qg	_	10.5	_	nC	V _{DS} = -15V, I _D = -6A
Gate-Source Charge	Q _{gs}	_	1.8	_	nC	
Gate-Drain Charge	Q _{gd}	_	1.9	_	nC	1
Turn-On Delay Time	t _{D(on)}	_	6.8	_	ns	
Turn-On Rise Time	t _r	_	4.9	_	ns	$V_{DD} = -15V, V_{GS} = -10V,$
Turn-Off Delay Time	t _{D(off)}	_	28.4	_	ns	$R_G = 6\Omega$, $I_D = -1A$
Turn-Off Fall Time	tf	_	12.4	_	ns	7
Reverse Recovery Time	t _{rr}	_	14	_	ns	1 100 4:/44 5000//
Reverse Recovery Charge	Q _{rr}	_	11	_	nC	I _F = 12A, di/dt = 500A/μs

Notes:

^{7.} IAS and EAS rating are based on low frequency and duty cycles to keep $T_J = +25\,^{\circ}\text{C}$. 8. Short duration pulse test used to minimize self-heating effect. 9. Guaranteed by design. Not subject to product testing.



N-CHANNEL





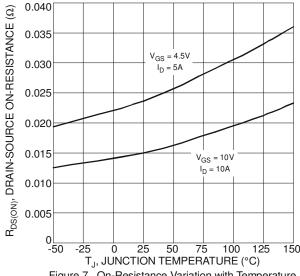
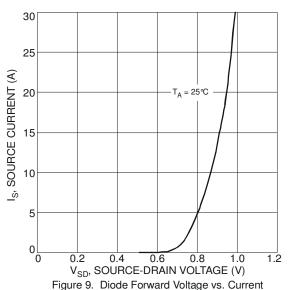
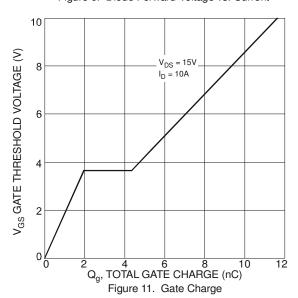


Figure 7. On-Resistance Variation with Temperature





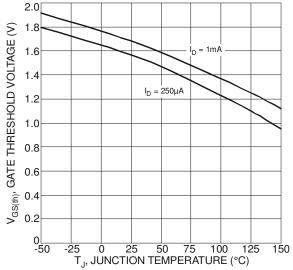
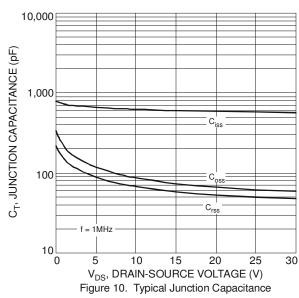


Figure 8 Gate Threshold Variation vs. Ambient Temperature



100 ⊨ R_{DS(on)} Limited ID, DRAIN CURRENT (A) $T_{J(max)} = 150 ^{\circ} C$ $T_{A} = 25 ^{\circ} C$ Single Pulse0.01 0.1 10 V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area



P-CHANNEL

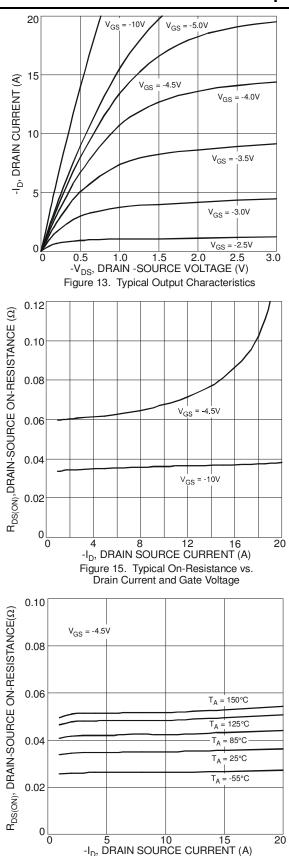
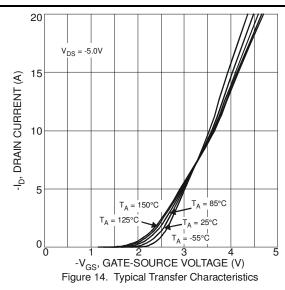
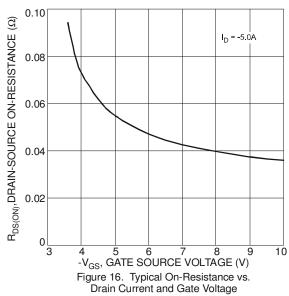


Figure 17. Typical On-Resistance vs. Drain Current and Temperature





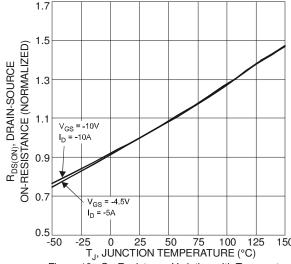
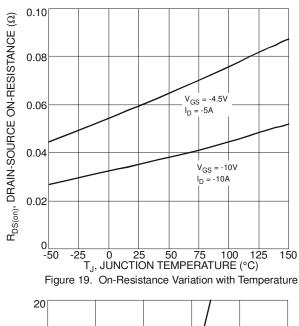
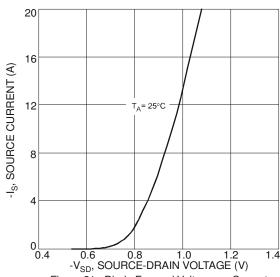
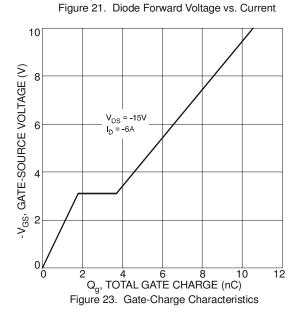


Figure 18. On-Resistance Variation with Temperature









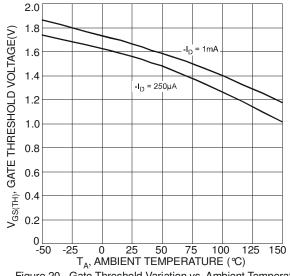
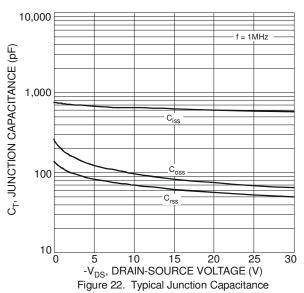
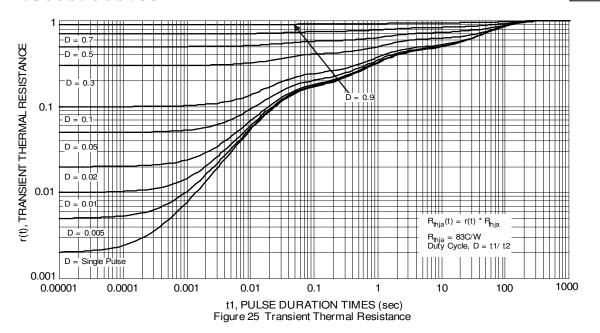


Figure 20. Gate Threshold Variation vs. Ambient Temperature



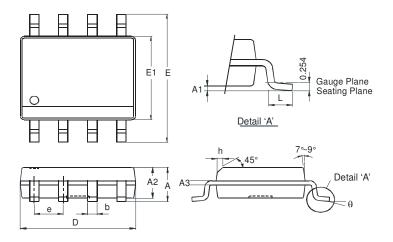
100 R_{DS(on)} Limited -I_D, DRAIN CURRENT (A) $T_{J(max)} = 150 \,^{\circ}$ C $T_A = +25 \,^{\circ}$ C Single Pulse 0.01 1 10 -V_{DS}, DRAIN-SOURCE VOLTAGE (V) 0.1 100 Figure 24. SOA, Safe Operation Area





Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

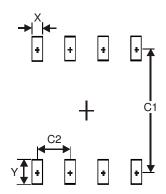


SO-8						
Dim	Min	Max				
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3	0.5				
D	4.85	4.95				
Е	5.90	6.10				
E1	3.85 3.95					
е	1.27	Тур				
h	- 0.35					
L	0.62 0.82					
θ	0° 8°					
All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

SO-8



Dimensions	Value (in mm)
X	0.60
Υ	1.55
C1	5.4
C2	1.27



IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body, or
 - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2015, Diodes Incorporated

www.diodes.com

10 of 10 DMC3025LSD February 2015 Document number: DS35717 Rev. 7 - 2 © Diodes Incorporated 单击下面可查看定价,库存,交付和生命周期等信息

>>Diodes Incorporated(达尔科技)